

Insulated Gate Bipolar Transistor (Trench IGBT), 80 A



PRIMARY CHARACTERISTICS					
V _{CES}	1200 V				
I _C DC	80 A at 104 °C				
V _{CE(on)} typical at 80 A, 25 °C	2.0 V				
Speed	8 kHz to 30 kHz				
Package	SOT-227				
Circuit configuration	Single switch with AP diode				

FEATURES

- Trench IGBT technology
- Positive V_{CE(on)} temperature coefficient
- Square RBSOA
- 10 µs short circuit capability
- HEXFRED® low Q_{rr}, low switching energy
- T_J maximum = 150 °C
- Fully isolated package
- Very low internal inductance (≤ 5 nH typical)
- · Industry standard outline
- UL approved file E78996



• Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

BENEFITS

- Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Easy to assemble and parallel
- · Direct mounting to heatsink
- Plug-in compatible with other SOT-227 packages
- · Low EMI, requires less snubbing

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter voltage	V _{CES}		1200	V	
Continuous collector current		T _C = 25 °C	139		
Continuous collector current	I _C	T _C = 90 °C	93		
Pulsed collector current	I _{CM}		170		
Clamped inductive load current	I _{LM}		250	А	
Diode continuous forward current		T _C = 25 °C	98		
	l _F	T _C = 90 °C	61		
Single pulse forward current	I _{FSM}	10 ms sine or 6 ms rectangular pulse, T _J = 25 °C	350		
Gate to emitter voltage	V_{GE}		± 20	V	
Power dissipation, IGBT		T _C = 25 °C	658		
	P _D	T _C = 90 °C	316	14/	
Power dissipation, diode		T _C = 25 °C	403	- W	
	P _D	T _C = 90 °C	194		
Isolation voltage	V _{ISOL}	Any terminal to case, t = 1 min	2500	V	



ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Collector to emitter breakdown voltage	V _{BR(CES)}	$V_{GE} = 0 \text{ V}, I_{C} = 2.6 \text{ mA}$	1200	-	-	
		$V_{GE} = 15 \text{ V}, I_{C} = 80 \text{ A}$	1	2.0	2.55	
Collector to emitter voltage	V _{CE(on)}	$V_{GE} = 15 \text{ V}, I_{C} = 80 \text{ A}, T_{J} = 125 \text{ °C}$	-	2.4	-	V
	. ,	$V_{GE} = 15 \text{ V}, I_{C} = 80 \text{ A}, T_{J} = 150 ^{\circ}\text{C}$	-	2.5	-	
Gate threshold voltage	V _{GE(th)}	$V_{CE} = V_{GE}$, $I_C = 2.6 \text{ mA}$	4.75	5.7	7.0	
Temperature coefficient of threshold voltage	$\Delta V_{GE(th)}/\Delta T_{J}$	$V_{CE} = V_{GE}$, $I_{C} = 2.6$ mA (25 °C to 125 °C)	-	-12	-	mV/°C
Collector to emitter leakage augrent	_	$V_{GE} = 0 \text{ V}, V_{CE} = 1200 \text{ V}$	-	1.0	100	μA
Collector to emitter leakage current	ICES	$V_{GE} = 0 \text{ V}, V_{CE} = 1200 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$	-	0.9	-	mA
	V _{FM}	$I_F = 80 \text{ A}, V_{GE} = 0 \text{ V}$	-	2.9	3.5	
Forward voltage drop		$I_F = 80 \text{ A}, V_{GE} = 0 \text{ V}, T_J = 125 \text{ °C}$	-	3.1	-	V
		I _F = 80 A, V _{GE} = 0 V, T _J = 150 °C	-	3.1	-	
Gate to emitter leakage current	I _{GES}	$V_{GE} = \pm 20 \text{ V}$	-	-	± 220	nA

SWITCHING CHARACTERISTICS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS	3	MIN.	TYP.	MAX.	UNITS
Total gate charge (turn-on)	Qg	V _{GE} = -15 V, V _{GE} = ± 15 V		-	570	-	
Input capacitance	C _{ies}	V _{CE} = 25 V, V _{GE} = 0 V, f = 1 MHz		-	4400	-	nE.
Reverse transfer capacitance	C _{res}	V _{CE} = 25 V, V _{GE} = 0 V, I = I IVIH2		-	235	-	pF
Turn-on switching loss	E _{on}	I _C = 80 A, V _{CC} = 600 V, V _{GF} = 15 V,		-	3.0	-	
Turn-off switching loss	E _{off}	$R_g = 1.0 \Omega, L = 500 \mu H,$		-	3.2	-	mJ
Total switching loss	E _{tot}	T _J = 25 °C		-	6.2	-	
Turn-on switching loss	E _{on}		Energy losses include tail and diode recovery Diode used HFA16PB120	-	3.9	-	mJ
Turn-off switching loss	E _{off}			-	5.5	-	
Total switching loss	E _{tot}			-	9.4	-	
Turn-on delay time	t _{d(on)}	I_C = 80 A, V_{CC} = 600 V, V_{GE} = 15 V, R_a = 1.0 Ω, L = 500 μH, T_J = 125 °C		-	134	-	
Rise time	t _r	rig = 1.0 32, Ε = 000 μri, 1j = 120 °C		-	65	-	
Turn-off delay time	t _{d(off)}			-	281	-	ns
Fall time	t _f			-	155	-	
Reverse bias safe operating area	RBSOA	T_J = 150 °C, I_C = 250 A, R_g = 1.0 Ω , V_{GE} = 15 V to 0 V, V_{CC} = 800 V, V_P = 1200 V, L = 500 μH		ı	Fullsquare	9	
Diode reverse recovery time	t _{rr}			ı	179	-	ns
Diode peak reverse current	I _{rr}	I _F = 50 A, dI _F /dt = 200 A/μs, V _R = 400 V		ı	11.5	-	Α
Diode recovery charge	Q _{rr}			ı	1029	-	nC
Diode reverse recovery time	t _{rr}	$I_{F} = 50 \text{ A, } dI_{F}/dt = 200 \text{ A/}\mu\text{s,} \\ V_{rr} = 400 \text{ V, } T_{J} = 125 \text{ °C} \\ \hline -$		-	275	-	ns
Diode peak reverse current	I _{rr}			-	17.8	-	Α
Diode recovery charge	Q _{rr}			-	2451	-	nC
Short circuit safe operating area	SCSOA	$V_{GE} = 15 \text{ V}, V_{CC} = 800 \text{ V}, V_{CE} \text{ max.} = 1200 \text{ V}, T_{J} = 150 \text{ °C}$ 10 µs				μs	

THERMAL AND MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Junction and storage temperature range	T _J , T _{Stg}		-40	-	150	°C
Junction to case IGBT Diode	R _{thJC}		-	-	0.19	
	□thJC		-	-	0.31	°C/W
Case to heatsink	R _{thCS}	Flat, greased surface	-	0.1	-	
Weight			-	30	-	g
Mounting torque		Torque to terminal	-	-	1.1 (9.7)	Nm (lbf. in)
Mounting torque		Torque to heatsink	-	-	1.3 (11.5))	Nm (lbf. in)
Case style		S	OT-227			

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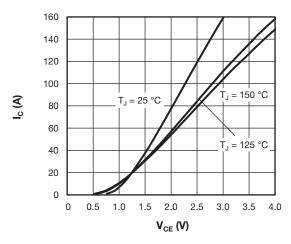


Fig. 1 - Typical IGBT Output Characteristics, $V_{GE} = 15 \text{ V}$

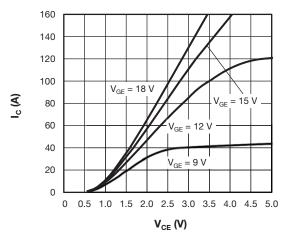


Fig. 2 - Typical IGBT Output Characteristics, T_J = 125 °C

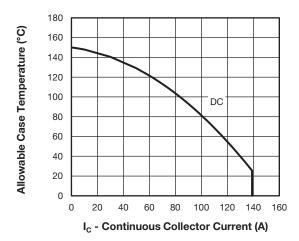


Fig. 3 - Maximum IGBT Continuous Collector Current vs. Case Temperature

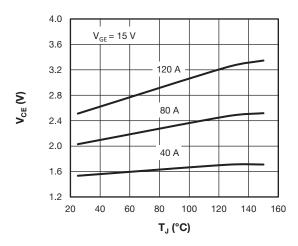


Fig. 4 - Collector to Emitter Voltage vs. Junction Temperature

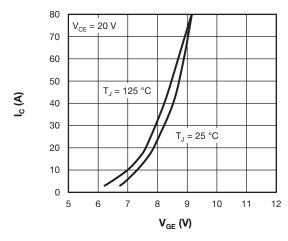


Fig. 5 - Typical IGBT Transfer Characteristics

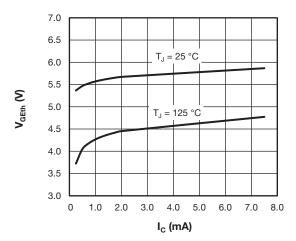


Fig. 6 - Typical IGBT Gate Threshold Voltage

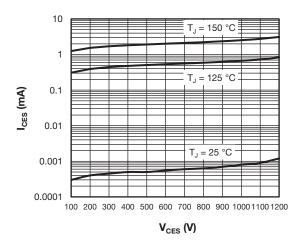


Fig. 7 - Typical IGBT Zero Gate Voltage Collector Current

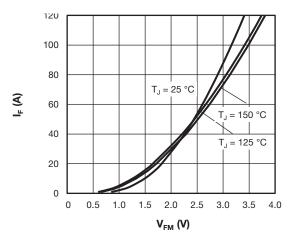


Fig. 8 - Typical Diode Forward Characteristics

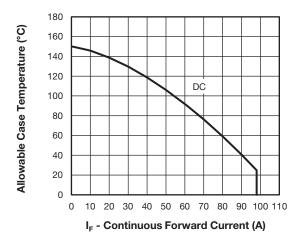


Fig. 9 - Maximum Diode Continuous Forward Current vs.
Case Temperature

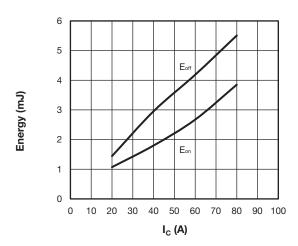


Fig. 10 - Typical IGBT Energy Loss vs I_C T_J = 125 °C, V_{CC} = 600 V, R_g = 1.0 Ω , V_{GE} = 15 V, L = 500 μ H

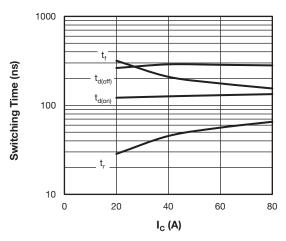


Fig. 11 - Typical IGBT Switching Time vs. I_C T_J = 125 °C, V_{CC} = 600 V, R_g = 1.0 $\Omega,$ V_{GE} = 15 V, L = 500 μH

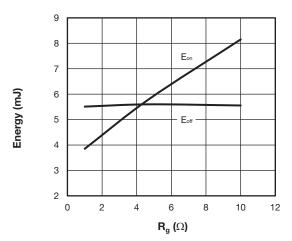


Fig. 12 - Typical IGBT Energy Loss vs. R_g T_J = 125 °C, V_{CC} = 600 V, I_C = 80 A, V_{GE} = 15 V, L = 500 μH



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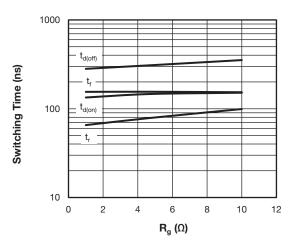


Fig. 13 - Typical IGBT Switching Time vs. R_g T_J = 125 °C, V_{CC} = 600 V, I_C = 80 A, V_{GE} = 15 V, L = 500 μH

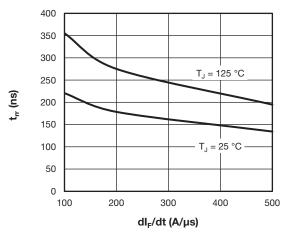


Fig. 14 - Typical Diode Reverse Recovery Time vs. dI_F/dt $V_{rr} = 400 \text{ V}, I_F = 50 \text{ A}$

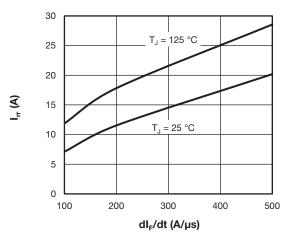


Fig. 15 - Typical Diode Reverse Recovery Current vs. dI_F/dt $V_{rr} = 400 \text{ V}, I_F = 50 \text{ A}$

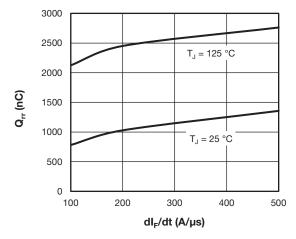


Fig. 16 - Typical Diode Reverse Recovery Charge vs. dI_F/dt $V_{rr} = 400 \text{ V}, I_F = 50 \text{ A}$

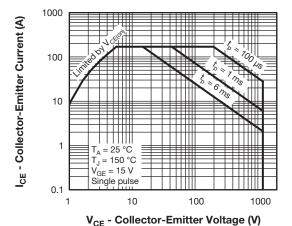


Fig. 17 - IGBT Safe Operating Area



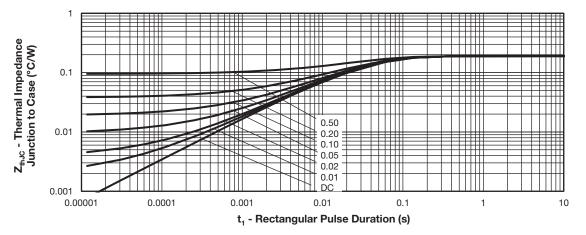


Fig. 18 - Maximum Thermal Impedance Z_{thJC} Characteristics (IGBT)

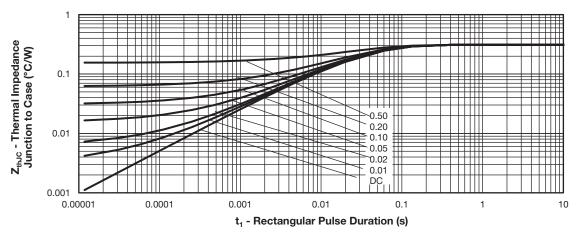


Fig. 19 - Maximum Thermal Impedance Z_{thJC} Characteristics (Diode)

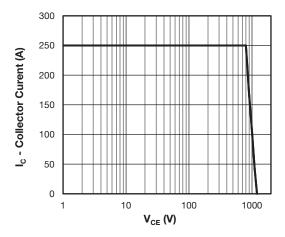
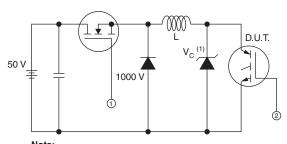


Fig. 20 - IGBT Reverse Bias SOA $V_{GE} = 15 \text{ V}, \, T_J = 150 \, ^{\circ}\text{C}$



Note: $^{(1)}$ Driver same type as D.U.T.; V_C = 80 % of V_{CE} max. Due to the 50 V power supply, pulse width, and inductor

Fig. 21 - Clamped Inductive Load Test Circuit

will increase to obtain ID

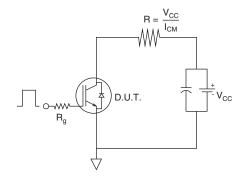


Fig. 22 - Pulsed Collector Current Test Circuit

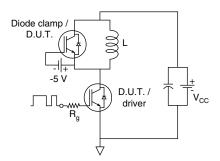


Fig. 23 - Switching Loss Test Circuit

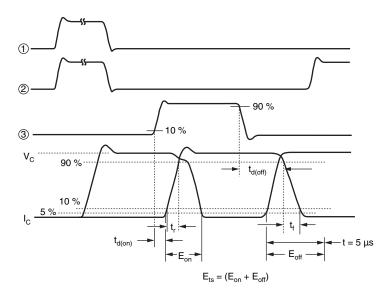
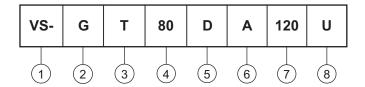


Fig. 24 - Switching Loss Waveforms Test Circuit

ORDERING INFORMATION TABLE

Device code



- 1 Vishay Semiconductors product
- Insulated gate bipolar transistor (IGBT)
- Trench IGBT technology
- 4 Current rating (80 = 80 A)
- 5 Circuit configuration (D = single switch with antiparallel diode)
- 6 Package indicator (A = SOT-227)
- 7 Voltage rating (120 = 1200 V)
- Speed / type (U = ultrafast)

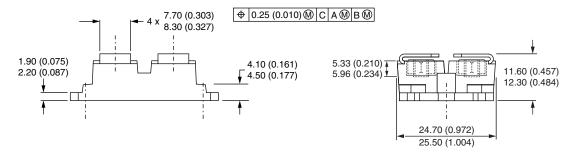
CIRCUIT CONFIGURATION						
CIRCUIT	CIRCUIT CONFIGURATION CODE	CIRCUIT DRAWING				
Single switch with AP diode	D	2 (G) 0 Lead Assignment 1 1 2 1 2 2				

LINKS TO RELATED DOCUMENTS					
Dimensions	www.vishay.com/doc?95423				
Packaging information	www.vishay.com/doc?95425				

SOT-227 Generation 2

DIMENSIONS in millimeters (inches)





Note

· Controlling dimension: millimeter



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